

Workshop on Advanced Data Collection with Multi-Axis Goniometry

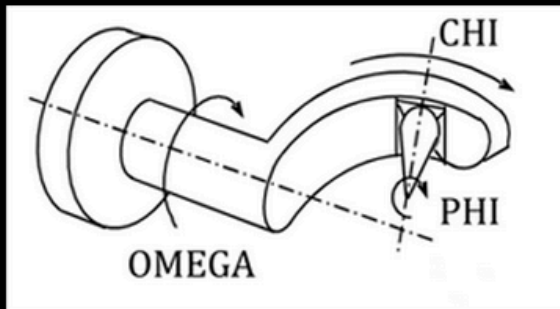


Wir schaffen Wissen – heute für morgen

Paul Scherrer Institut, Swiss Light Source

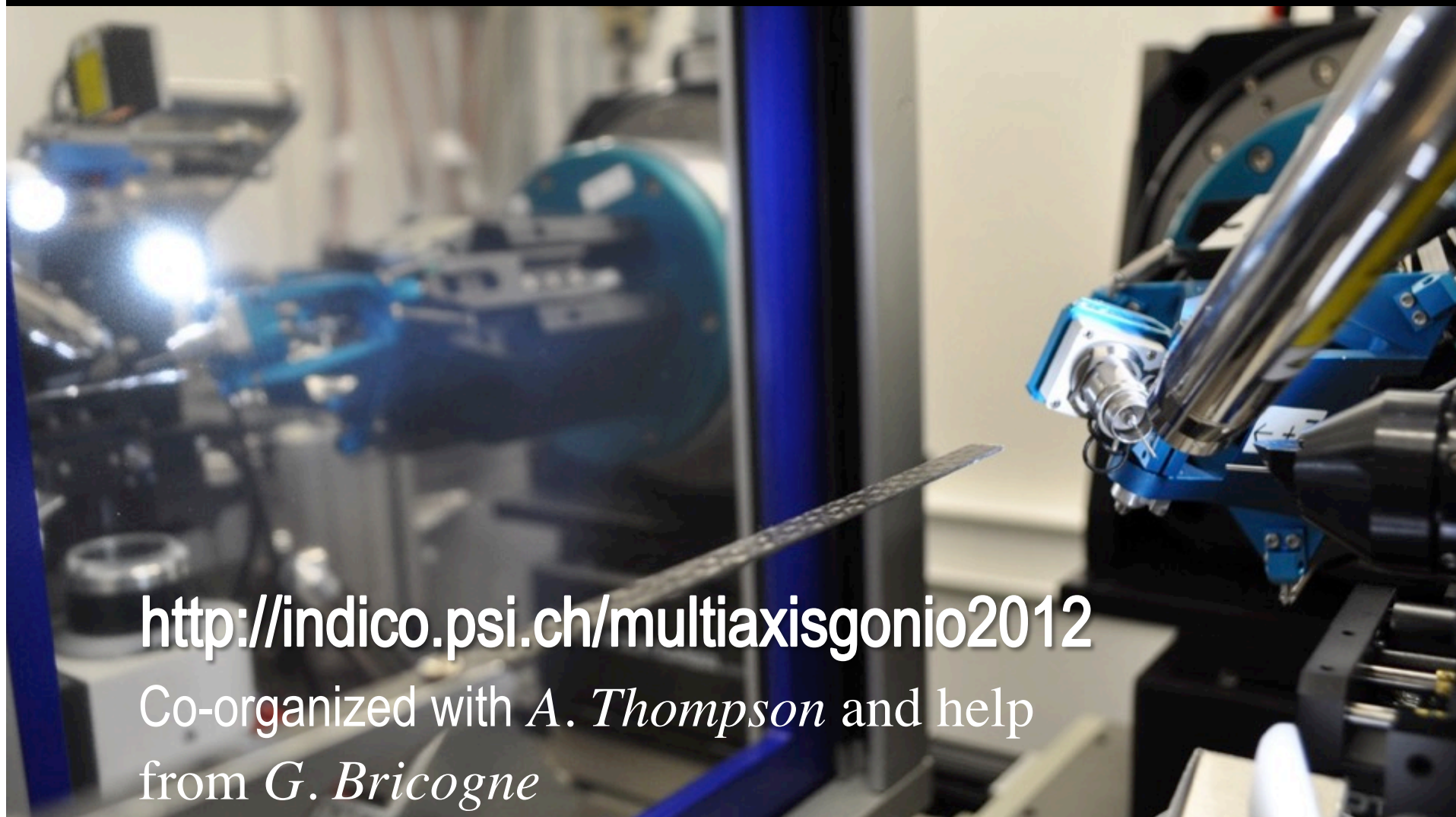
Meitian Wang

A Better Data Collection Strategy: You Can Always Use a Lower Dose



Workshop on Advanced Data Collection with Multi-Axis Goniometer and Single-Photon Counting Detector

6-8 November 2012 *Paul Scherrer Institut*
Europe/Zurich timezone



<http://indico.psi.ch/multiaxisgonio2012>

Co-organized with *A. Thompson* and help
from *G. Bricogne*

Three PX Beamlines at the Swiss Light Source

Beamline	PXI (X06SA)	PXII (X10SA)	PXIII (X06DA)
Source	U19	U19	2.9T Superbend
Energy range	6.0 – 17.5 keV	6.5 – 20.0 keV	5.5 – 17.5 keV
Flux, phs/s (12.4 keV, focused beam)	$2 \times 10^{11} \leftrightarrow 2 \times 10^{12}$	2×10^{12}	5×10^{11}
Beamsize, μm^2 (with focusing, slits)	$2 \times 1 \leftrightarrow 100 \times 100$ (fast beam size change)	50×10 $30 \times 10, 20 \times 10, 10 \times 10$	$80 \times 45 \mu\text{m}^2$
Goniometer	Micro-diffractometer (SmarGon)		Multi-axis, PRiGo (SmarGon)
Detector	EIGER 16M	PILATUS 6M	PILATUS 2M
Data collection time	2 – 3 minutes		
Sample changer	IRELEC CATS		
Industrial usage	15%	50%	40%

Unique volume and unique reflections

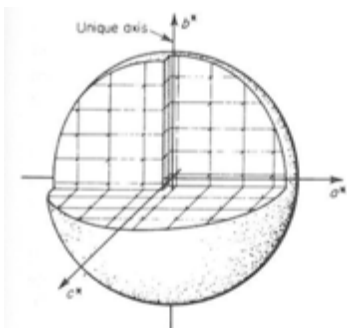


Figure 6.6. Unique volume in reciprocal space for a monoclinic crystal.

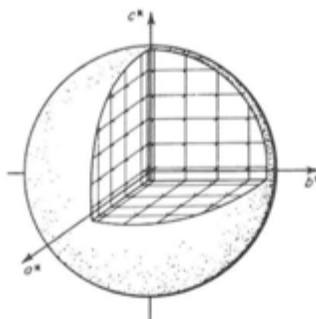


Figure 6.7. Unique volume in reciprocal space for an orthorhombic crystal.

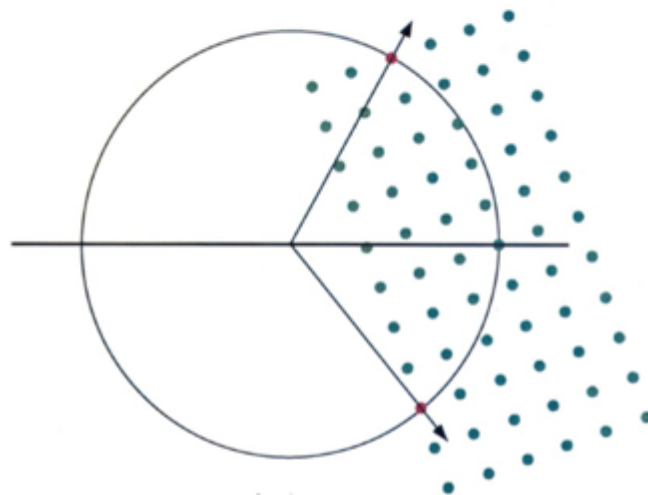
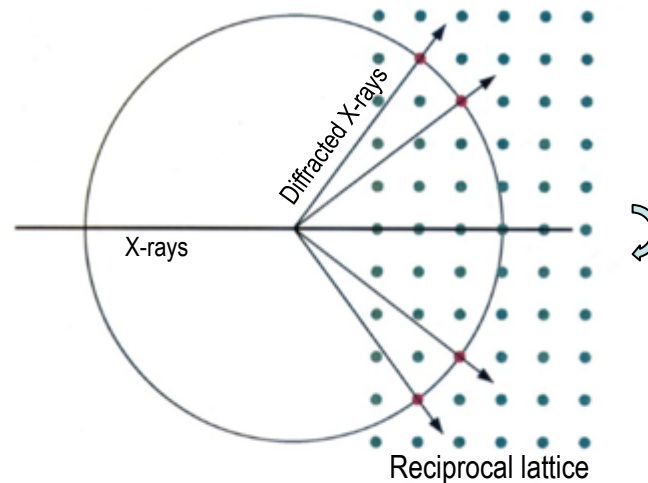


Table 1

Rotation range ($^{\circ}$) required to collect a complete data set in different crystal classes.

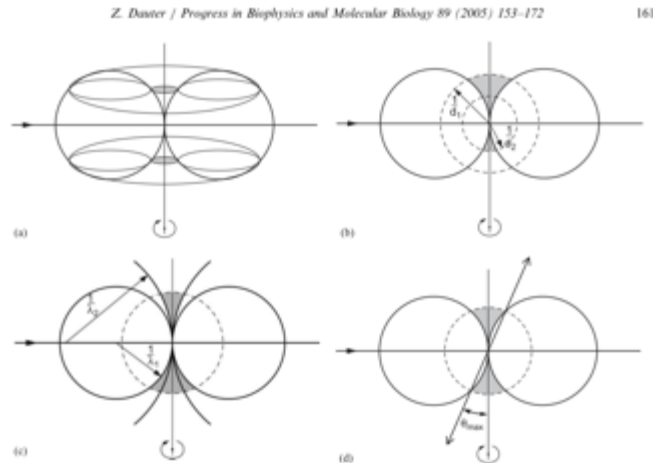
The direction of the spindle axis is given in parentheses; *ac* means any vector in the *ac* plane.

Point group	Native data	Anomalous data
1	180 (any)	180 + 2 θ_{\max} (any)
2	180 (<i>b</i>); 90 (<i>ac</i>)	180 (<i>b</i>); 180 + 2 θ_{\max} (<i>ac</i>)
222	90 (<i>ab</i> or <i>ac</i> or <i>bc</i>)	90 (<i>ab</i> or <i>ac</i> or <i>bc</i>)
4	90 (<i>c</i> or <i>ab</i>)	90 (<i>c</i>); 90 + θ_{\max} (<i>ab</i>)
422	45 (<i>c</i>); 90 (<i>ab</i>)	45 (<i>c</i>); 90 (<i>ab</i>)
3	60 (<i>c</i>); 90 (<i>ab</i>)	60 + 2 θ_{\max} (<i>c</i>); 90 + θ_{\max} (<i>ab</i>)
32	30 (<i>c</i>); 90 (<i>ab</i>)	30 + θ_{\max} (<i>c</i>); 90 (<i>ab</i>)
6	60 (<i>c</i>); 90 (<i>ab</i>)	60 (<i>c</i>); 90 + θ_{\max} (<i>ab</i>)
622	30 (<i>c</i>); 90 (<i>ab</i>)	30 (<i>c</i>); 90 (<i>ab</i>)
23	~60	~70
432	~35	~45

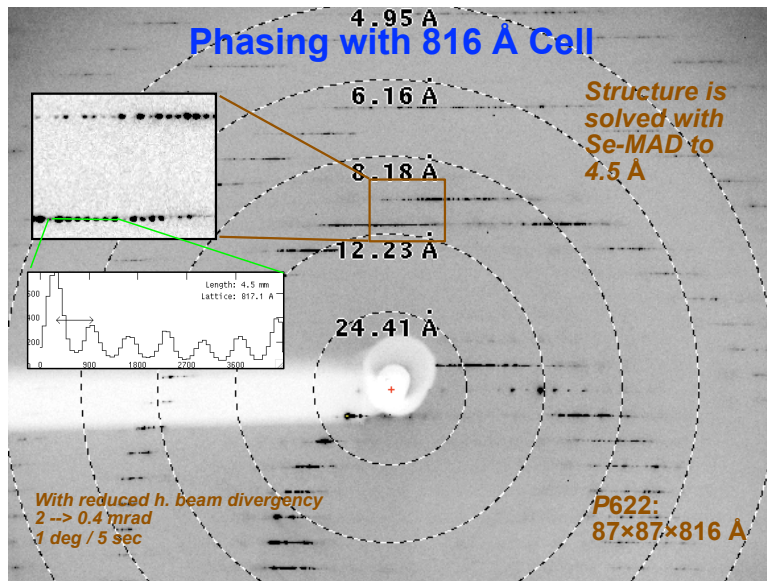
Rotation method and rotation range

Stout and Jensen (1989), Dauter, *Acta Cryst. D55*, 1703 (1999)

- Avoid blind region

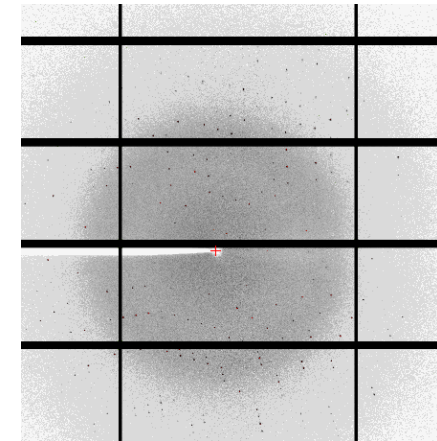
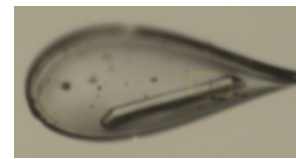


- Align long unit-cell axis to avoid spots overlaps

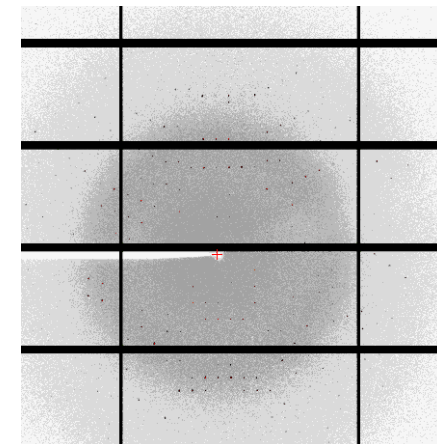


- Align even-fold rotation axis to record Bijvoet pairs on the same image

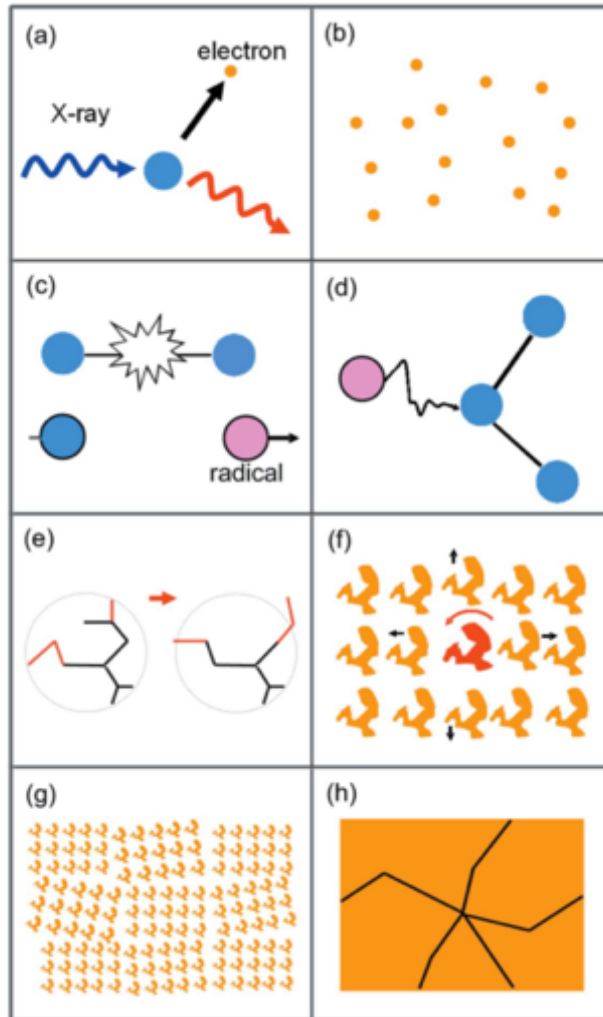
Misaligned:



Aligned to twofold:



(XOAlign, Stratcalc)



M. Warkentin *et al.* *J. Synchrotron Rad.* **20**, 7 (2013)

Native data collection (20 MGy)

- Henderson, *Proc. R. Soc. B.* **241**, 6 (1990)
- Owen, *et al. Proc. Natl. Acad. Sci. USA*, **103**, 4912 (2006)

Experimental phasing (< 5 MGy)

- Holton, *J. M. J. Synchrotron Rad.* **14**, 51 (2007)
- Olieric, *et al. Acta Cryst.* **D63**, 759 (2007)

Rule of thumb

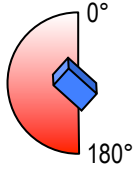
- Resolution dependency of 10 MGy / Å, Howells *et al. J. El. Spect. & Rel. Phen.* **170**, 4 (2009)
- Scaling *B* factor vs. dose of ~ 1 *B*-factor / MGy, Kmetko *et al. Acta Cryst.* **D62**, 1030 (2006)
- Dose estimation, Holton, *J. Synchrotron Rad.* **16**, 133 (2009)

$$Dose = (t_{expo} \times flux) / (k_{dose} \times I_{H-beam} \times I_{B-beam})$$

$$k_{dose} = 2000\lambda^{-2}$$

“Traditional” Data Collection Strategy

High-dose low multiplicity data collection strategy
(180° data within dose limit)



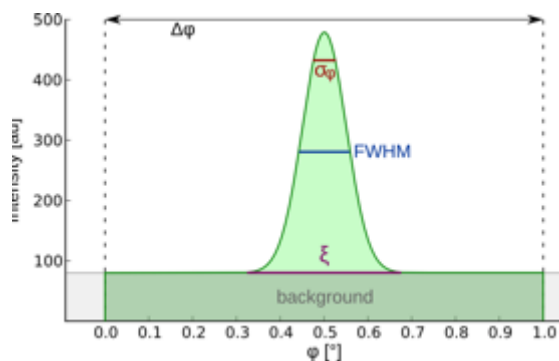
Random errors, counting statistics

$$\sigma_{count} = N^{1/2}$$

$$I = N_p - N_b \quad \text{Signal is the difference}$$

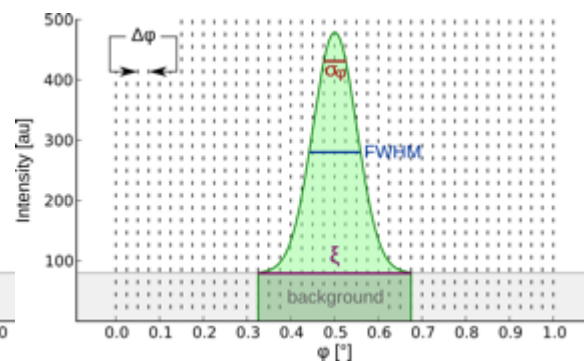
$$\sigma_I = (\sigma_p^2 + \sigma_b^2)^{1/2}$$

$$\sigma_I = (N_p + N_b)^{1/2} \quad \text{Uncertainty is the sum}$$



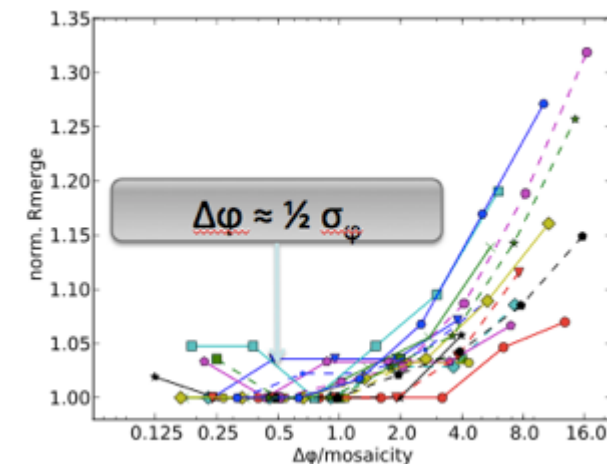
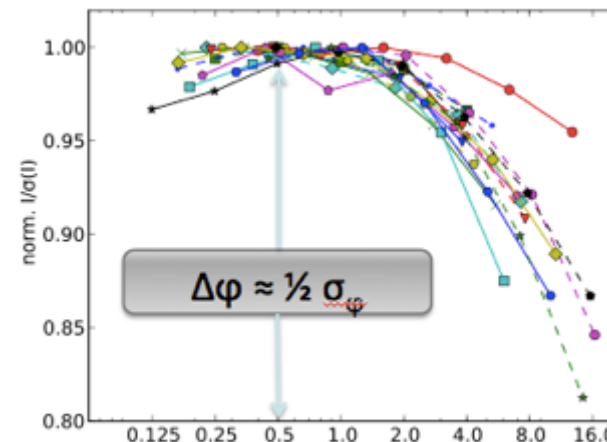
Wide φ -slicing

- Large $\Delta\varphi$ ($\Delta\varphi > \xi$)
- Large overlap of reflections and background along φ
- Few images



Fine φ -slicing

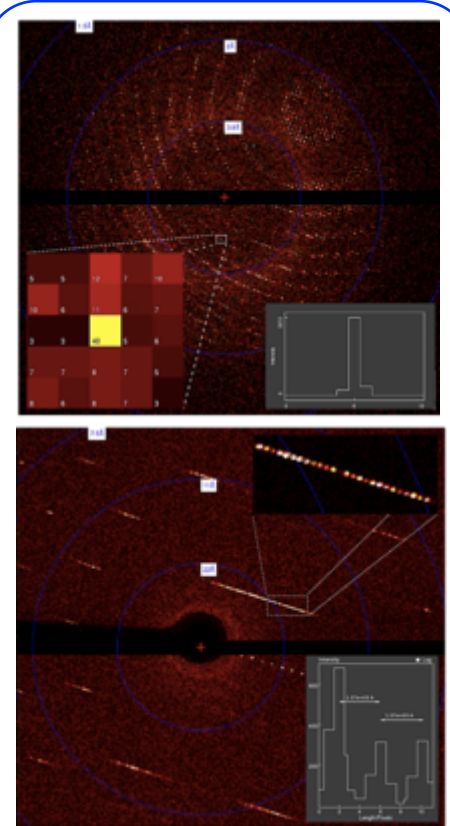
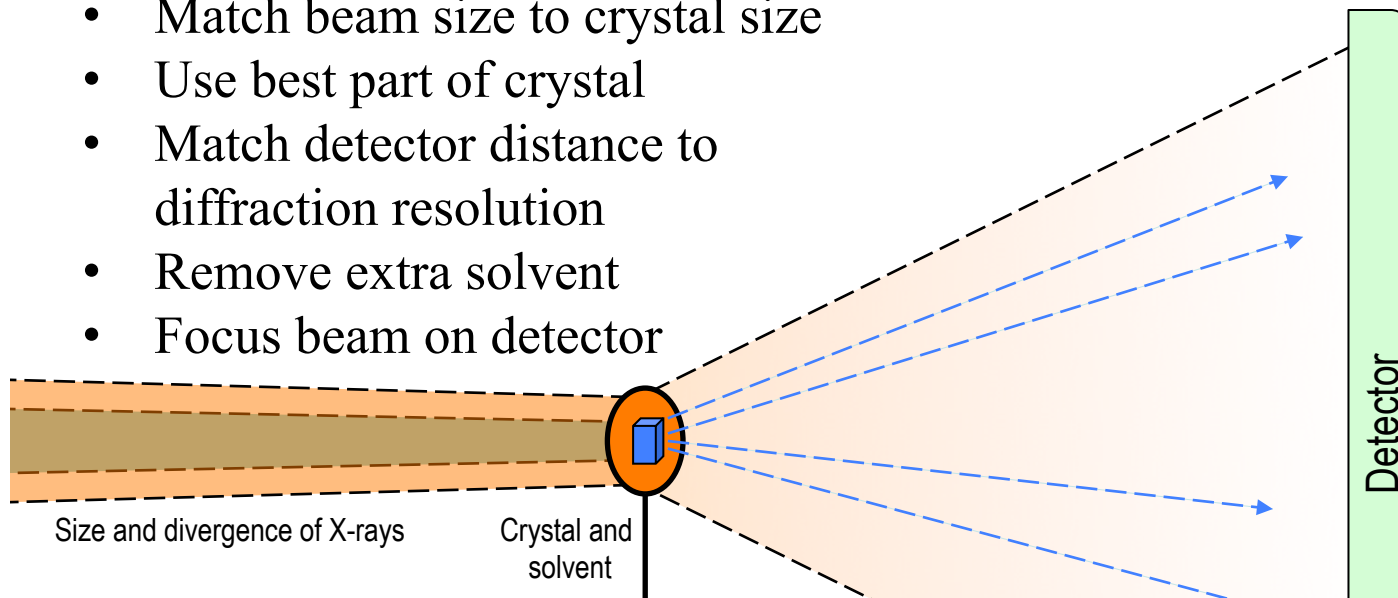
- Small $\Delta\varphi$ ($\Delta\varphi \ll \xi$)
- Minimal overlap of reflections and background along φ
- Many images



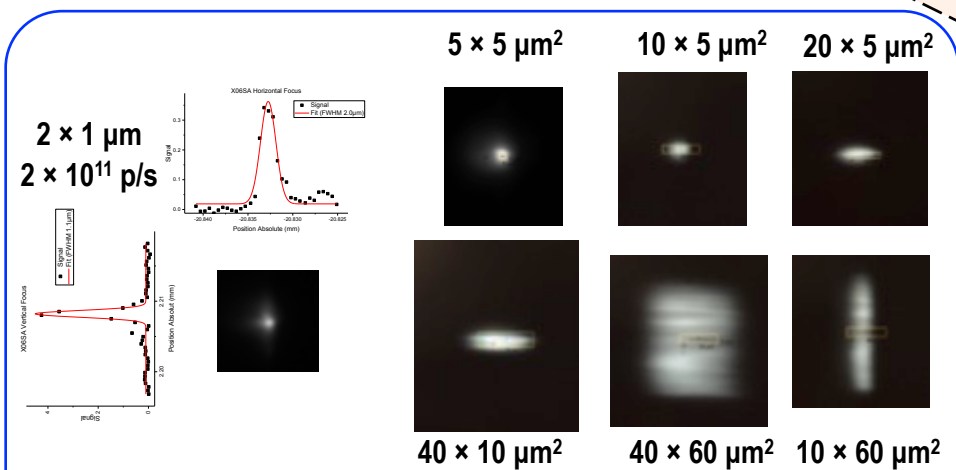
Fine-phi slicing data collection is enabled by the pixel array detector (PILATUS, EIGER), which has single-photon sensitivity and no readout noise

Intensity Data Collection: Reduce Background

- Match beam size to crystal size
- Use best part of crystal
- Match detector distance to diffraction resolution
- Remove extra solvent
- Focus beam on detector



Spot resolution with EIGER 16M detector (75 μm pixel) at beamline PXI, SLS



Variable beam size from 1 to 200 μm at beamline PXI, SLS



- *Precision* of measurements tells us how much they differ *from each other*
- To increase *precision* → repetitive measurements (high multiplicity) within radiation damage limit
- *Accuracy* of measurements tells us how much they differ *from the truth*, but the truth is not known
- To improve *accuracy* → reduce systematic errors: beam stability, diffraction geometry, crystal orientation, absorption and variation, detector non-ideality, ...
- All data quality indicators measure precision, not accuracy!

Random errors, counting statistics

$$\sigma_{count} = N^{1/2}$$

$$I = N_p - N_b \quad \text{Signal is the difference}$$

$$\sigma_I = (\sigma_p^2 + \sigma_b^2)^{1/2}$$

$$\sigma_I = (N_p + N_b)^{1/2} \quad \text{Uncertainty is the sum}$$

Systematic errors, instrumental instability

$$\sigma_{sys} = k_I I \quad (\text{typical range of } k_I \text{ is } 0.001 \text{ to } 0.01)$$

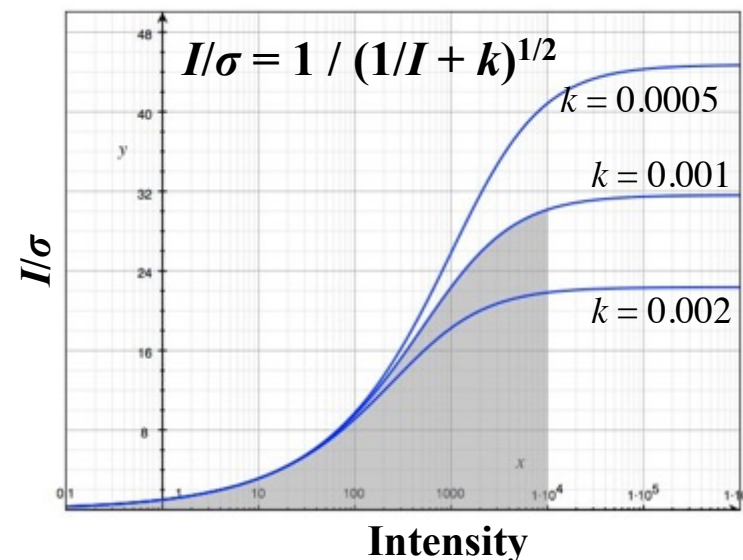
$$\sigma = (\sigma_{count}^2 + \sigma_{sys}^2)^{1/2}$$

$$\sigma_{count} \sim I^{1/2} \quad ; \quad \sigma_{sys} \sim I$$

$$\sigma = (I + kI^2)^{1/2}$$

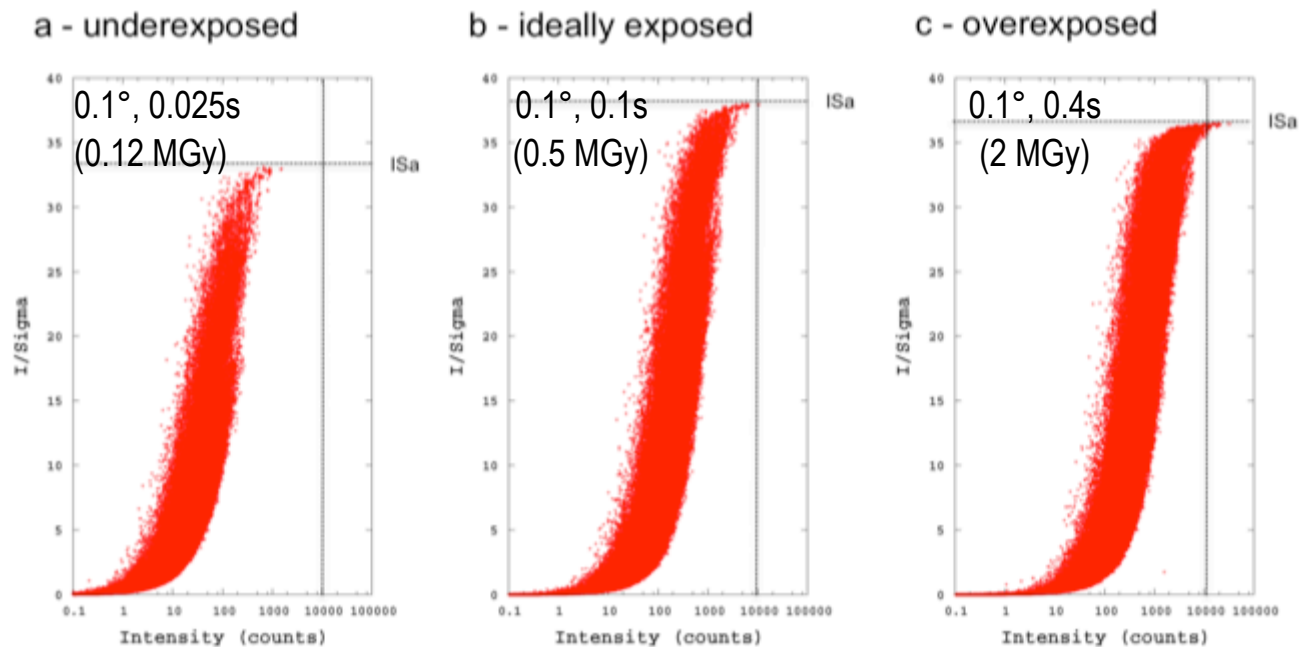
$$I/\sigma = I / (I + kI^2) = 1 / (1/I + k)^{1/2}$$

Asymptotic behavior of I/σ (ISa)



Achievable I/σ is limited by systematic errors, ISa

Best exposure? You Can Always Use a Lower Dose

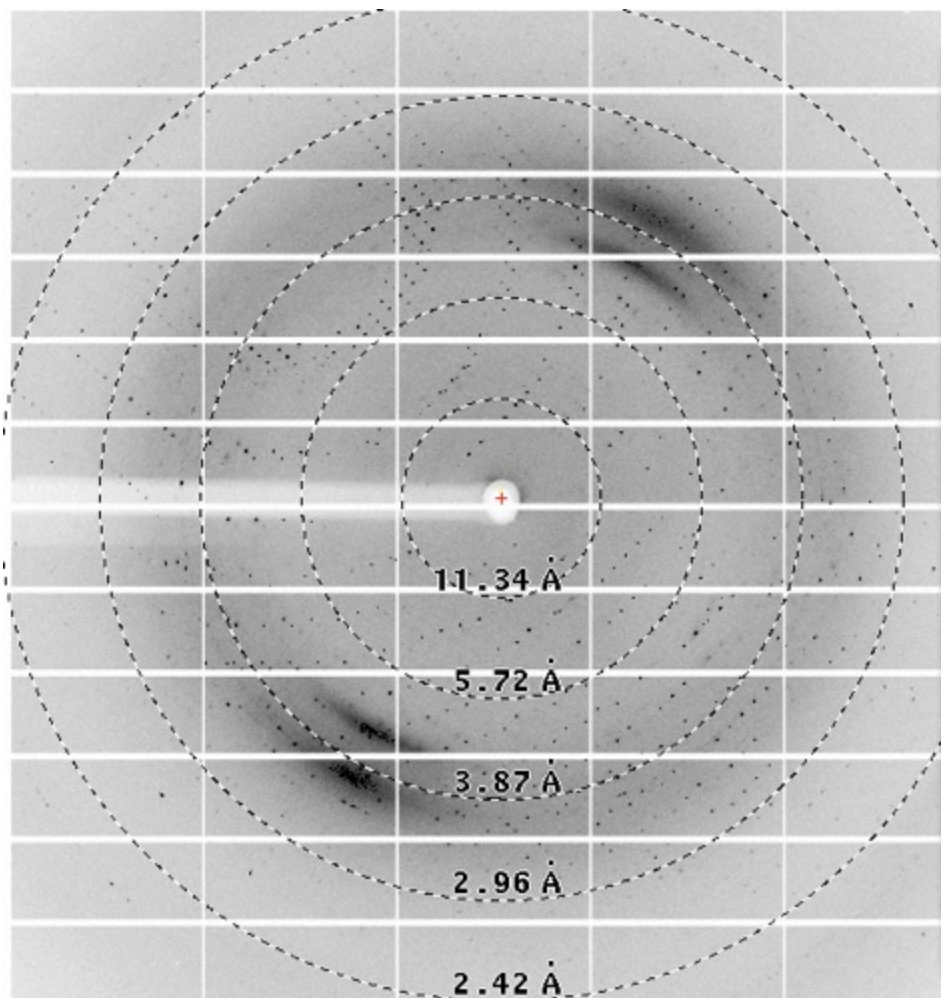


$(I/\sigma)^{\text{asymptotic}}$ plots of data sets of 180° collected at 6 keV with 1.5×10^{10} photons/s

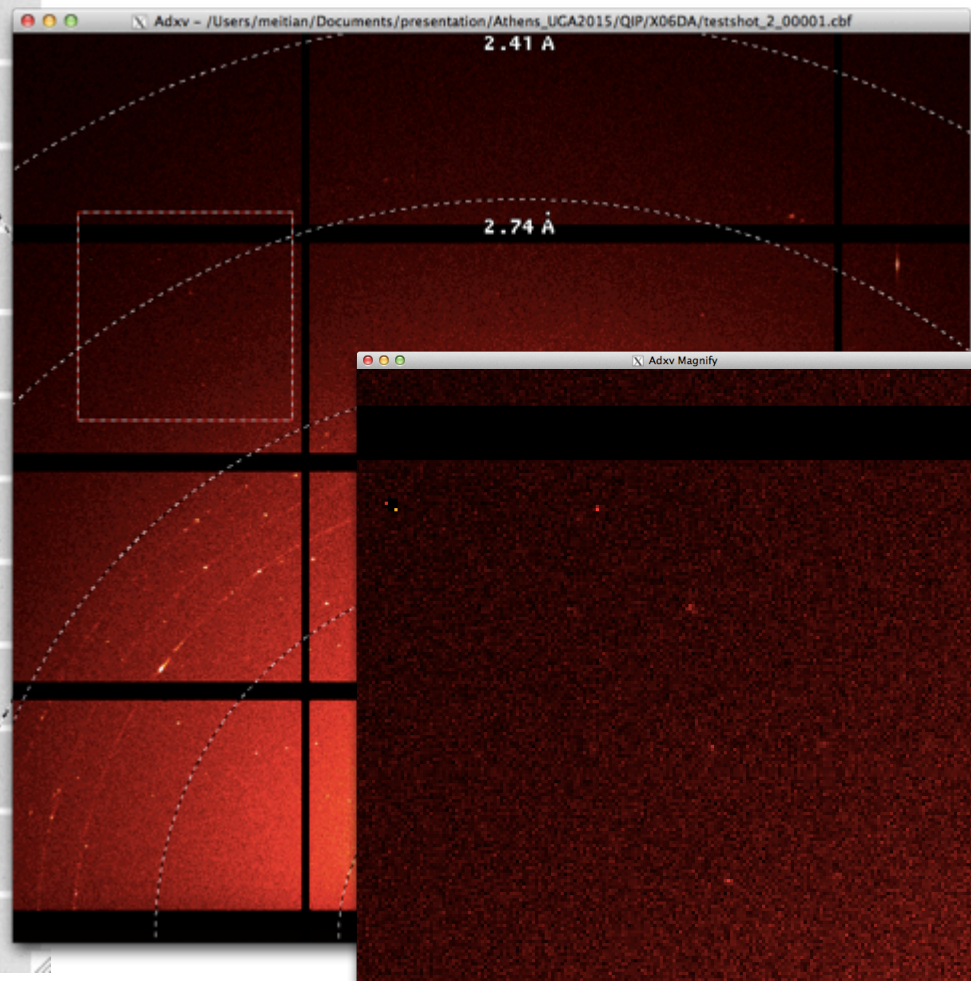
- Achievable I/σ at low-med resolution (phasing) is limited by systematic error
- Achievable I/σ at high resolution (refinement) is limited by counting statistics
- Low I/Sa means high systematic error
- Good datasets have $I/Sa > 30$, bad ones < 10

Diederichs, *Acta Cryst.* **D66**, 733 (2010)

Lower Dose Example



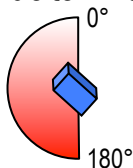
**1 sec exposure with 1.5×10^{11} ph/sec
1° oscillation at beamline X10SA, SLS**



**1 sec exposure with 1.5×10^{10} ph/sec
0.5° oscillation at beamline X06DA, SLS**

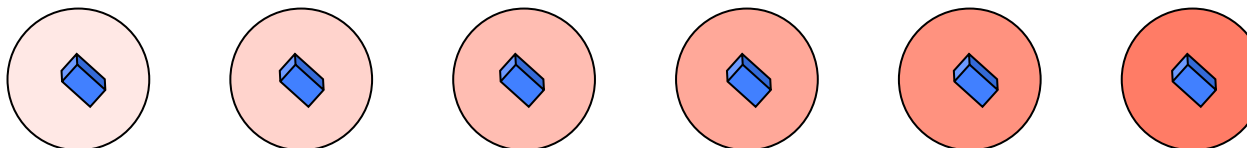
High-dose low multiplicity data collection strategy

(180° data within dose limit)



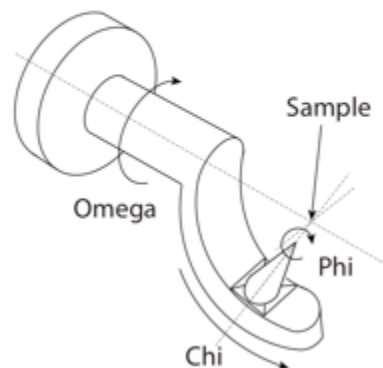
Dose-slicing high multiplicity data collection strategy, Liu *et al. Acta Cryst.* **A67**, 544, (2011)

($n \times 360^\circ$ data within dose limit)

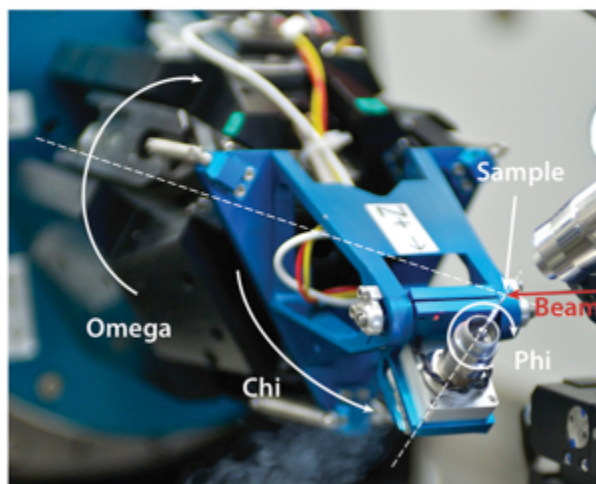


Multi-orientation data collection with multi-axis goniometer

a)



b)



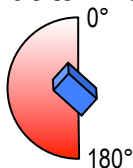
Manipulating crystal orientation changes

- 1) Diffraction geometry**
- 2) X-ray absorption path**
- 3) Position of reflections on detector**

Sampling diffraction geometry, absorption path, and detector surface to average out systematic measurement errors

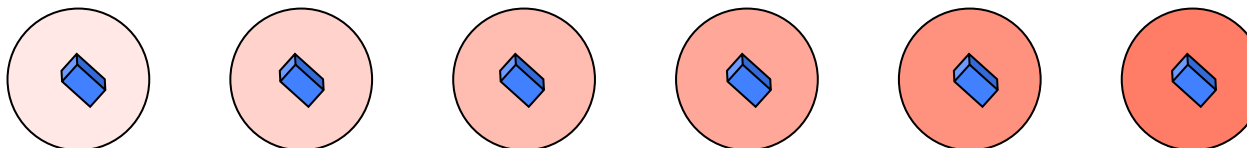
High-dose low multiplicity data collection strategy

(180° data within dose limit)



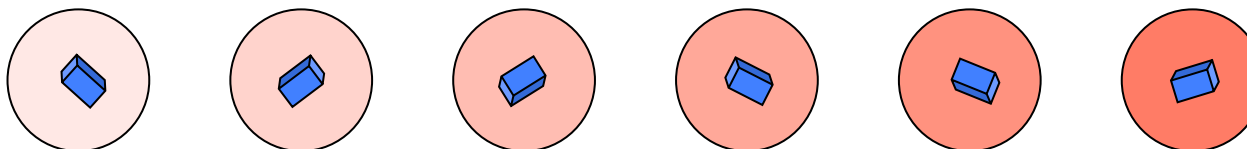
Dose-slicing high multiplicity data collection strategy, Liu *et al. Acta Cryst.* **A67**, 544, (2011)

($n \times 360^\circ$ data within dose limit)



Multi-orientation high multiplicity data collection strategy, Weinert *et al. Nature Methods* **12**, 131, (2015)

($n \times 360^\circ$ data in multiple crystal orientation within dose limit)



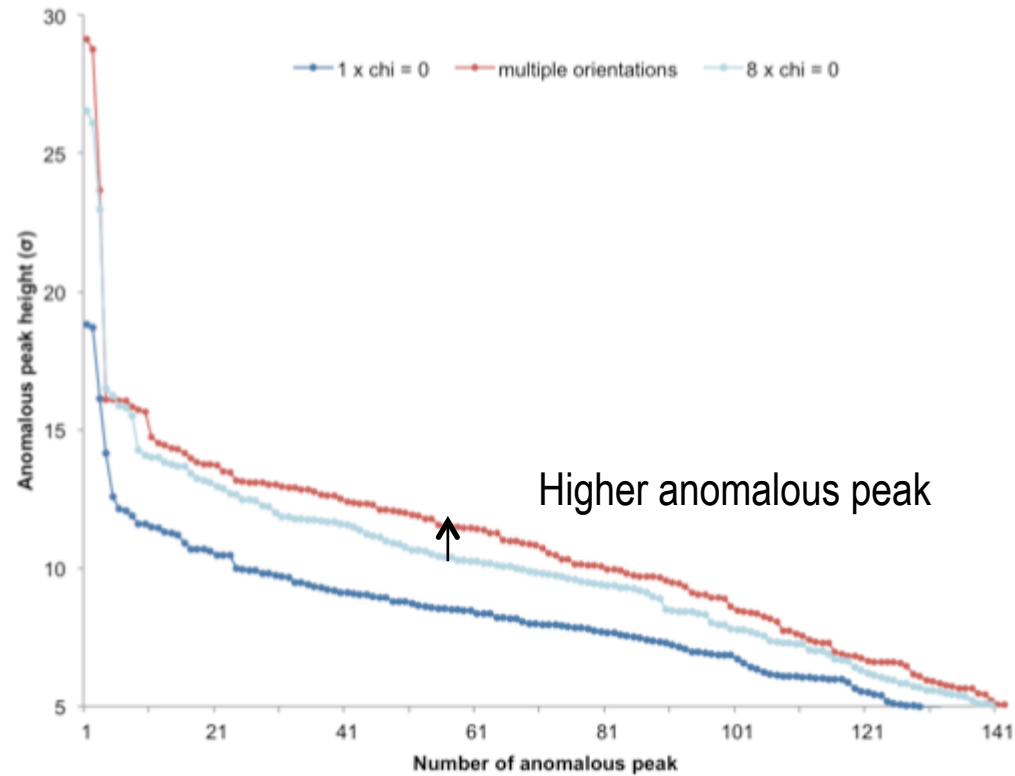
Advantage of Multi-Orientation Strategy

Crystal



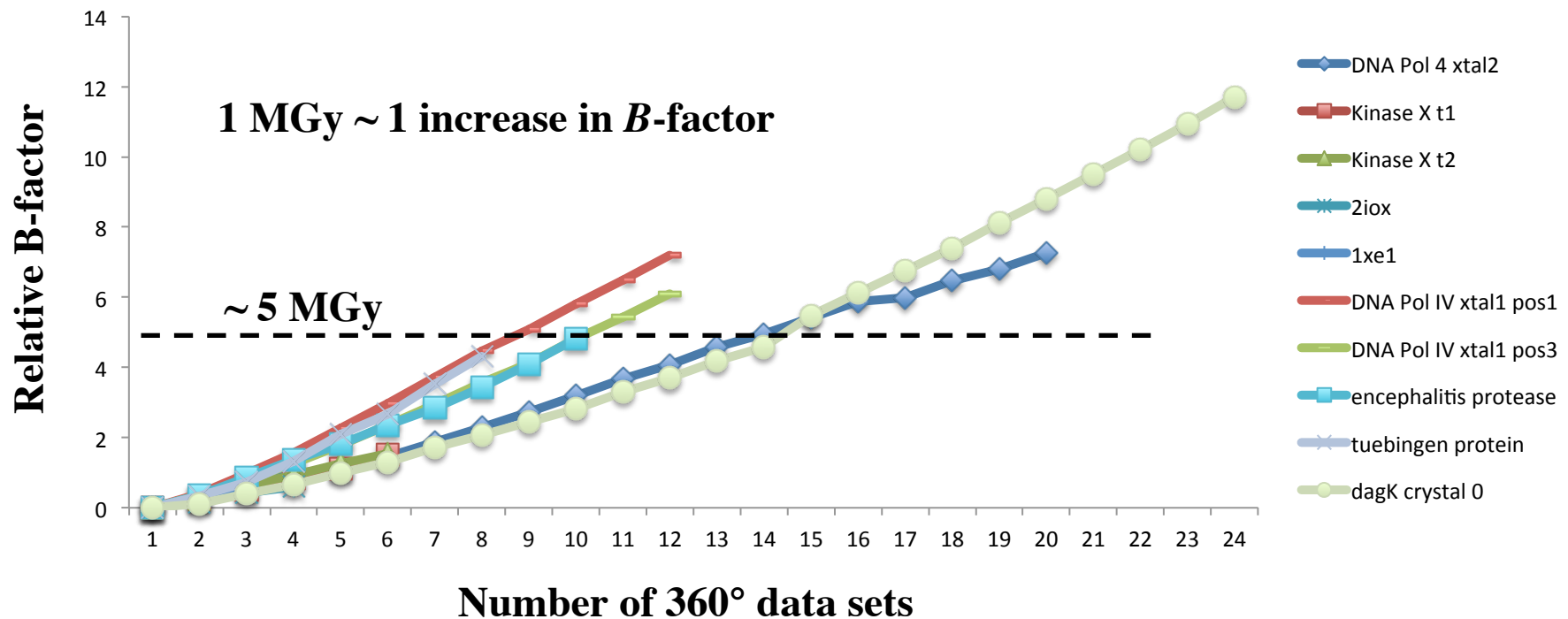
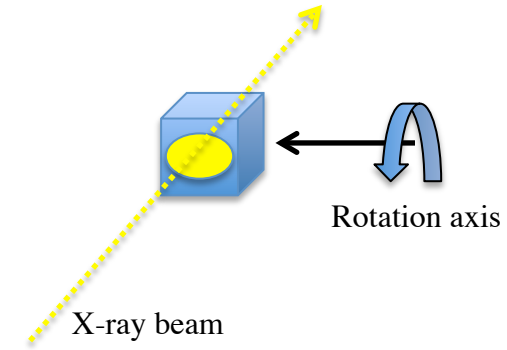
Omega

Sample	Dataset	Orientation, χ	Time	Native-SAD
Position 1	0.1° / 0.1 s, 720°	0°, 10°, 20°, 30°	48 min	✓
Position 2	0.1° / 0.1 s, 720°	0° (<i>i.e.</i> one orientation)	48 min	✗



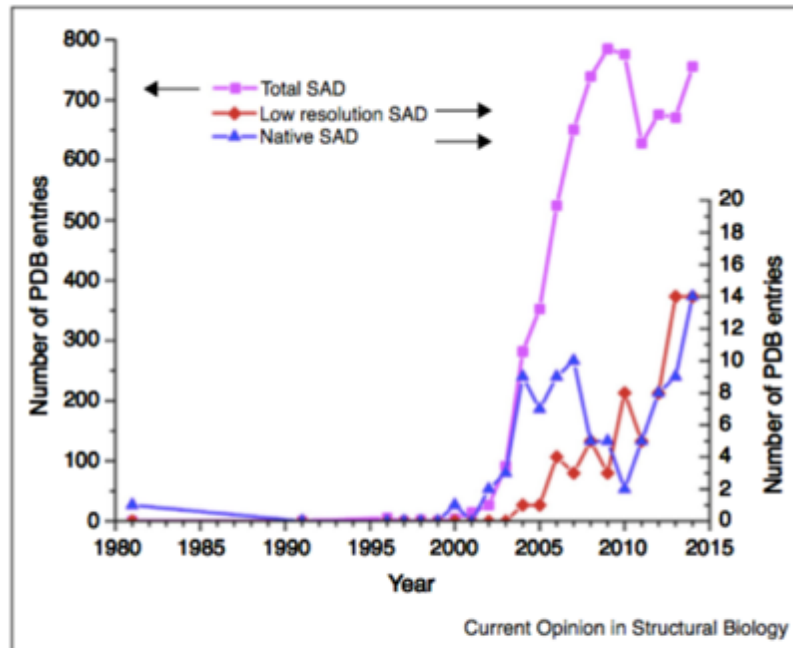
Low-Dose Strategy Allows Radiation Damage Control

Crystal size $100 \times 100 \times 100 \mu\text{m}^3$
 X-ray beam size $90 \text{ (h)} \times 45 \text{ (v)} \mu\text{m}^3$
 6 keV, 1.5×10^{10} ph/sec
 → about 0.5 MGy/360 sec, 360° data



- Phasing by anomalous dispersion has been and still is by far the most popular *de novo* structure determination method

Figure 1



SAD structures in the PDB. PDB entries are as of 31 December 2014. *De novo* low-resolution SAD structures as defined here have $d_{\min} \geq 3.5 \text{ \AA}$. *De novo* native-SAD structures as defined here have no preceding PDB deposits and have not contained atoms heavier than atomic number 20.

Current challenges

- Low-res SAD with $d > 3.5 \text{ \AA}$
- Native-SAD with $Z < 20$
(Vincent Olieric's talk in Session II)

Liu & Hendrickson Curr. Opin. Struc. Bio. **34**, 99 (2015)

Distributing tolerable X-ray dose into multiple data sets measured at different crystal orientation can improve accuracy of intensity measurement

Low-dose, high-multiplicity, multi-orientation data collection strategy helps in abstracting weak anomalous signals for experimental phasing

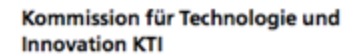
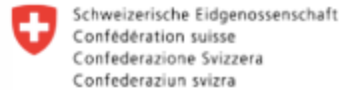
Development in synchrotron beamline X-ray optics, multi-axis goniometer and pixel array detector has changed MX data collection strategies

X06SA micro-focusing upgrade



Clemens Schulze-Briese, Claude Pradervand, Roman Schneider, James Leuenberger, and MX group

EIGER 16M



Stefan Brandstetter, Clemens Schulze-Briese, Andreas Förster, Oliver Bunk, Arnau Casanas, and MX group

PRIGo/SmarGon/Native-SAD



Tobias Weinert, Vincent Olieric, Sandro Waltersperger, Claude Pradervand,, Ezequiel Panepucci

Data processing

Kay Diederichs

Global Phasing Ltd.

Many many collaborators providing test crystals and ideas!

Thank you for your attention!

